

# APPLICATION DATA SHEET

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Title of Invention: TEST KEY FOR DETECTING ELECTRICAL ISOLATION BETWEEN A WORD LINE AND A DEEP TRENCH CAPACITOR IN DRAM CELLS

Customer Number Attorney: 027765



Customer Number Correspondence Address: 027765



## INVENTOR(s):

Primary Citizenship: R.O.C.

Given Name: Chih-Cheng

Family Name: Liu

Residence City: Taipei Hsien

Residence Country: TW

Address: No.9-1, Lane 153, Han-Sheng W. Rd.,Pan-Chiao City,  
Taipei Hsien, Taiwan, R.O.C.  
Taipei Hsien , TW

Primary Citizenship: R.O.C.

Given Name: Wei-Wu

Family Name: Liao

Residence City: Taipei Hsien

Residence Country: TW

Address: 2F, No.14, Yueh-Wang Rd., Jui-Fang Town, Taipei Hsien,  
Taiwan, R.O.C.  
Taipei Hsien , TW

Primary Citizenship: R.O.C.  
Given Name: Chuan Fu  
Family Name: Wang  
Residence City: Taipei Hsien  
Residence Country: TW  
Address: 3F, No. 5, Lane 397, Jen-Ai ST., San-Chung City, Taipei  
Hsien, Taiwan, R.O.C.  
Taipei Hsien , TW